


<b>Search Notes</b> 	<b>Application/Control No.</b> 10089178	<b>Applicant(s)/Patent Under Reexamination</b> HIBINO ET AL.
	<b>Examiner</b> DEVONA E FAULK	<b>Art Unit</b> 2615

SEARCHED			
Class	Subclass	Date	Examiner
381	86	5/31/06	BTP
381	86,302,102-109	4/26/07	DEF
381	86,302,102-109	5/19/08	DEF
455	345,569.2	5/20/08	DEF
381	302,86	12/7/08	DEF
381	302,86,102-109,74,24,25	5/7/09	DEF
455	569.2,345	5/7/09	DEF
381	102-109,86,302,74	11/20/09	DEF
455	569.2,345	11/20/09	DEF
381	102-109,86,302,74	3/1/10	DEF
455	569.2,345	3/1/10	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
Assignee/Inventor search	4/26/07	
reviewed applicant's arguments, maintained rejection	10/18/07	DEF
additional search	5/19/08	DEF
additional search	12/7/08	DEF
additional search	5/7/09	DEF
additional search	11/20/09	DEF
additional search	3/1/10	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	combined class/word search	3/1/10	DEF

	/DEVONA E FAULK/ Primary Examiner.Art Unit 2614
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